

Application No.	Applicant(s)	
09/940,757	WEI ET AL.	
Examiner	Art Unit	
Minh Trinh	3729	

SEARCHED					
Class	Subclass	Date	Examiner		
29	As previous searched	5/10/2004	-mt-		
257					
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Databases Text, image search updated (see printout attached)	5/10/2004	W-		
Reviewed the following Patents US 6,630,772, US 5,973,444 and all references cited therein				
Consulted w/Pexr Carl Arbes 5/10/04				